

**Search Notes**

Application/Control No.

09/670,489

Examiner

Cong-Lac Huynh

Applicant(s)/Patent under  
Reexamination

MARUYAMA ET AL.

Art Unit

2178

**SEARCHED**

Class	Subclass	Date	Examiner
715	513	8/16/2005	CLH
	500	8/16/2005	CLH
717	143	8/16/2005	CLH
707	101	8/16/2005	CLH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	513	8/16/2005	CLH
707	101	8/16/2005	CLH
Interference Search History Printout		8/16/2005	CLH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (US PG PUB, US PAT, EPO, JPO, Derwent, IBM_TDB)	8/16/2005	CLH
ACM	8/11/2005	CLH
ProQuest	8/15/2005	CLHI
IEEE	8/15/2005	CLH